Electronic Transport in Metal Nanocrystal Arrays: The Effect of Structural Disorder on Scaling Behavior

Raghuveer Parthasarathy, Xiao-Min Lin, and Heinrich M. Jaeger

James Franck Institute and Department of Physics, University of Chicago, Chicago, Illinois 60637 (Received 21 February 2001; published 16 October 2001)

We investigate the impact of structural disorder on electronic transport in gold nanocrystal monolayers. Arrays ranging from void-filled networks to well-ordered superlattices show clear voltage thresholds (V_T) due to Coulomb blockade, and temperature-independent conduction indicative of quantum tunneling. Current-voltage characteristics of arrays with and without long-range structural order were found to collapse onto distinct scaling curves. The former follow a single power law: $I \sim (V - V_T)^{\zeta}$, $\zeta = 2.25 \pm 0.1$. The latter show additional structure, reflecting the underlying disordered topology.

DOI: 10.1103/PhysRevLett.87.186807 PACS numbers: 73.22.-f, 05.60.Gg, 73.40.Gk, 89.75.Da

The intriguing electronic and optical properties of individual nanocrystal quantum dots have unleashed a flood of interest [1]. However, despite such discoveries as metalinsulator-type transitions in squeezed nanocrystal monolayers [2] and spin-dependent transport in magnetic particle assemblies [3], the simplest nanoparticle array — a single layer of metal nanocrystals — has remained poorly understood. The main reason is that the transport characteristics are strongly affected by three types of disorder: global structural disorder in the array topology, local structural disorder in the interparticle couplings, and local charge disorder due to random, immobile charges in the underlying substrate. Theoretical approaches investigating tunneling transport so far have concentrated on local charge disorder alone [4]. A full treatment of the combined types of disorder is not available, even though large differences between spatially ordered and disordered structures might be expected due to the sensitivity of percolative charge transport phenomena to array topology and the exponential dependence of local tunneling resistances on the interparticle spacings. With nanocrystal arrays as "artificial solids" [5] expected to provide useful analogs and tunable test beds for various bulk correlated electron systems, a full understanding of metal nanocrystal monolayers is vital.

Experimentally, a high degree of structural order has been elusive for arrays between in-plane electrodes, and previous investigations of electrical conduction in such systems have been performed only on small, highly disordered, or multilayered arrays [3,6–8]. Using newly developed self-assembly techniques, we have fabricated large highly ordered monolayers of dodecanethiol-ligated gold nanocrystals on substrates with in-plane electrodes. Transport measurements and subsequent transmission electron microscopy (TEM) on the same arrays allowed for direct correlation of electronic and structural characteristics. Comparison of these superlattices with void-filled networks for the first time delineates the roles played by the different types of disorder.

Nanocrystals were deposited on silicon substrates coated with 100 nm amorphous silicon nitride (Si₃N₄) (Fig. 1a). Under a 70 μ m \times 70 μ m area, the Si was etched away to leave a freestanding Si₃N₄ membrane "window," allowing TEM imaging [9]. Thin (20 nm) Cr electrodes were patterned using electron-beam lithography. The 1-dodecanethiol ligated gold nanocrystals were synthesized as described in Ref. [10] and dissolved in toluene to a concentration of about 2.4 \times 10¹³ ml⁻¹. The gold core radii varied from sample to sample (2.2–2.9 nm), but for each sample were monodisperse to within 5%.

Two different array preparation techniques yielded two distinct classes of arrays: samples with and without large-scale structural disorder. Simple deposition of 15-20 µl of colloid onto a substrate produced, upon drying, a nanocrystal monolayer of well-packed regions with short-range order, coexisting with numerous voids (area fraction 15%-20%) throughout the 2D plane (Fig. 1b). Higher particle concentrations produced an increased amount of multilayered regions without increasing the long-range order. However, addition of excess dodecanethiol (volume fraction 6.3×10^{-3}) to the solution before deposition increased the nanocrystal mobility on the Si₃N₄ surface and prevented rapid dewetting of the solvent from the substrate. As a result, arrays with significantly smaller void or double layer fraction (about 5% combined) and excellent long-range periodicity could be self-assembled (Figs. 1c and 1d) [11].

Much larger contiguous paths of nanocrystals are found in the arrays with long-range order than in the void-ridden arrays. Directly relevant to the transport behavior is the probability density, P(n), of a nanocrystal being in a linear segment of n particles uninterrupted by voids. Our long-range ordered arrays yielded a broad P(n), with an expectation value $\langle n \rangle \sim N$, the length between electrodes and the natural length scale of the arrays. In the other class of arrays, P(n) decreased sharply with n, and gave $\langle n \rangle \sim 0.25N$ [12].

Electronic properties of a total of 14 arrays were measured (7 prepared without and 7 with excess ligand),

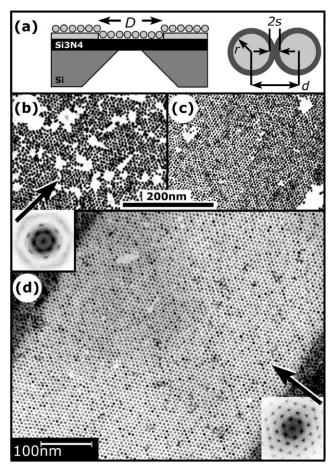


FIG. 1. (a) Sketch of a nanocrystal monolayer and in-plane electrodes (not to scale), and of the interparticle geometry. (b) TEM image (detail) of a typical array formed *without* excess dodecanethiol, showing many voids and an absence of long-range order. The 2D Fourier transform (2DFT) is of a larger area. (c) Typical superlattice formed *with* excess dodecanethiol, showing <5% voids and long-range ordering. (d) Highly ordered superlattice (and 2DFT) between electrodes visible at the upper left and lower right. The random nanocrystal image intensities are due to random Bragg diffraction of the electron beam.

with dimensions defined by the electrode separations (200 nm < D < 700 nm) and widths (fixed at 2 μ m). The resulting $N \times M$ arrays ranged in length from N = 30 to 90 particles and were $M \approx 270$ nanocrystals wide.

The samples were cooled, in vacuum, to below 77 K to avoid parasitic conduction through the substrates. dc current-voltage (IV) characteristics were measured using Keithley 614 electrometers and a voltage source. Control measurements on substrates without monolayers showed no detectable currents ($<0.02~\rm pA$) up to $\pm20~\rm V$. We imaged each array by TEM after the transport measurements. From analysis of the center-to-center distances, d, and the particle radii, r, distributions of the interparticle spacings 2s = d - 2r (Fig. 1a) were obtained, resulting in $s = 0.85~\pm~0.1~\rm nm$ for the arrays with voids. For the well-ordered superlattices the excess dodecanethiol increased the mean spacing to $s = 1.2~\pm~0.1~\rm nm$.

The IV curves (Fig. 2) were highly symmetric, of the same overall shape for all samples, and showed no hysteresis at the slow ramp rates used ($\sim 5 \text{ mV/s}$). The strongly non-Ohmic behavior, in which current flow requires the applied voltage to exceed a finite threshold, is characteristic of Coulomb blockade of transport [3,7,13–15]. The electrostatic energy needed to add one electron to a quantum dot of charge q and (self-)capacitance $C_0 =$ $4\pi\epsilon\epsilon_0 r$ leads to a single-particle Coulomb blockade voltage, $V_0 = q/C_0$, below which tunneling is suppressed (Fig. 2, lower inset). For $V > V_0$, current flows with resistance R = dV/dI; $R \gg h/e^2$ for our nanocrystals. The overall IV characteristic then arises from the seriesparallel combination of many tunneling paths from particle to particle throughout the array. Random, parasitic charges in the substrate—local charge disorder—induce the effective charges $q \in (0, e)$ on the nanocrystals, randomly placing the local V_0 in the interval $(0, e/C_0)$, but leaving R unchanged. Local structural disorder, on the other hand, produces variations in the tunnel distance, 2s, and thus a wide (most likely log-normal) distribution of R, leaving V_0 essentially unchanged [16]. The exponential dependence of R on s makes a large variance in the interparticle resistances almost a certainty, even in well-assembled arrays (e.g., Fig. 1d).

Using the dielectric constant $\epsilon \approx 2$ for dodecanethiol, and q = e/2, we find $C_0 \approx 0.5$ aF and $V_0 \approx 150$ mV for a typical Au nanocrystal. The capacitance between neighboring particles [17], based on the geometry observed by TEM, is $C_{12} = 0.25$ aF $< C_0$. In this regime of small interparticle capacitive coupling, hysteresis due to longrange charge rearrangements is not expected [4]. Furthermore, for all accessible temperatures $e^2/\max\{C_0, C_{12}\} \gg k_BT$ and thus the array transport properties are essentially temperature independent (Fig. 2). This behavior implicates direct, interparticle quantum tunneling as the conduction mechanism and is in contrast to the strong temperature dependence observed in other nanocrystal systems with large Coulomb blockade voltages [3,6]. Arrhenius behavior in those systems we believe is due to

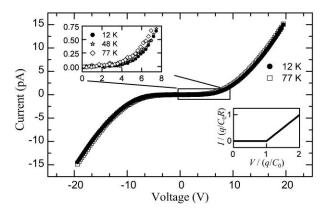


FIG. 2. IV curves for a typical superlattice ($D=330~{\rm nm}\times{\rm width}~2~\mu{\rm m}$). The upper inset magnifies the data. The lower inset shows a schematic IV curve for a single nanocrystal, as described in the text.

186807-2 186807-2

activated hopping via trapping sites provided by electronrich π -bonded linker molecules attached to the metal particle cores. This difference between tunneling and activated hopping suggests that chemical modifications to nanocrystalline systems may change fundamentally the physics governing transport, and highlights two different routes towards control of nanostructure conductance: physical tailoring of separations between metal cores and chemical manipulation of molecular links between the cores.

How charge disorder alone affects the global IV characteristics measured across large arrays has been calculated by Middleton and Wingreen (MW) [4] and by Roux and Herrmann [18]. They find a well-defined, global threshold voltage, V_T, which delineates a second order phase transition: for $V < V_T$ the array current is zero, and for $V > V_{\rm T}$ the array conducts with a power-law scaling form, $I \sim M(V_0/R)[(V - V_T)/V_T]^{\zeta}$. In Fig. 3 we plot the normalized current, $i = IR/(MV_0)$, as a function of normalized voltage above threshold, $v = (V - V_T)/V_T$, for all 14 measured arrays. The array width M was obtained from the TEM images. R we adjusted to obtain collapse of the curves. Typical R were around 50 and 300 T Ω for arrays without and with excess dodecanethiol, respectively, the increase corresponding to the increase in average particle spacing described above. These R are in accord with conducting-tip atomic force microscopy studies of tunneling through self-assembled alkanethiol monolayers [19]. Consistent choice of V_T (not far from the values estimated by eye from the IV curves, e.g., Fig. 2) produced a robust scaling behavior of the IVs for the ordered arrays assembled with excess ligands (Fig. 3a), yielding an average $\zeta = 2.25 \pm 0.1$.

The conductivity exponent ζ is related to the meandering of current paths in the charge-disordered landscape. Even in regular 2D arrays current paths are not straight,

but exhibit transverse fluctuations that extend a distance $\xi_{\perp} \propto v^{-\eta}$ due to the quenched charge disorder [4]. The total current above threshold across an array of width M is proportional to the number of independent parallel paths, M/ξ_{\perp} , which leads to $i \propto vM/\xi_{\perp} \propto Mv^{\eta+1}$, i.e., $\zeta =$ η + 1. The determination of the transverse correlation length exponent η arises in many physical phenomena connected to interface growth or directed percolation. In the absence of correlations between sites (a mean-field approach), $\eta = 1$ and $\zeta = 2$ [18]. MW argue that $\eta =$ 1/z, where z = 3/2 is the roughness exponent for Kardar-Parisi-Zhang (KPZ) models for interface growth in 2D [20]; thus $\zeta \approx 5/3$ [21]. Simulations show $\zeta \lesssim 2$ (i.e., $\eta \lesssim 1$) for square arrays of up to 400×400 particles [4,18]. The power-law form of the data in Fig. 3a suggests that scaling models are indeed valid, but the measured ζ is significantly larger than predicted by available theory.

Several previous experiments have reported a wide, sample-dependent spread in the scaling exponent: 1.4 < $\zeta < 2.0$ for lithographically patterned junction arrays [13,14], $1.6 < \zeta < 2.1$ for polydisperse nanocrystals [8], and $2.2 < \zeta < 2.7$ for small multilayered arrays [3]. This contrasts with the highly reproducible values we observe for ζ in the structurally ordered arrays. However, we find that arrays with large void fraction display i(v)scaling behavior with characteristic slope changes as well as larger sample-to-sample variations (Fig. 3b) [22]. The differences between the two classes of IVs may be understood in terms of changes in network topology. At large void fraction, neighboring voids produce bottlenecks, locally cutting off the transverse correlation length ξ_{\perp} . In the extreme case, conduction is reduced to several parallel 1D channels, each with linear $i \propto v$ but threshold V_T distributed over some range. For V barely larger than the smallest $V_{\rm T}$ only one channel is open and the overall IVis linear. As the applied voltage is increased, there will be

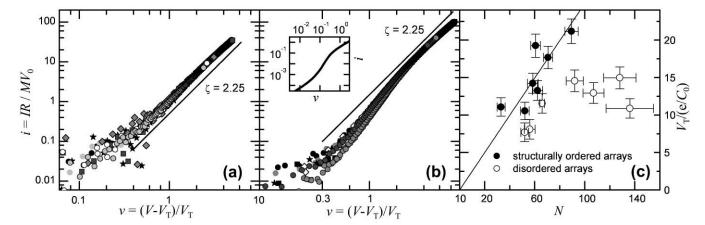


FIG. 3. Scaling behavior of IV curves. (a),(b) Log-log plots of all data with normalized voltage beyond threshold $v=(V-V_T)/V_T$ and current $i=IR/(MV_0)$ as described in the text. (a) Data from seven monolayers with long-range structural order. The solid line shows best-fit power-law $i=v^\zeta$ with $\zeta=2.25$. (b) Data from seven disordered monolayers. The solid line shows $\zeta=2.25$ as in (a). Inset: IV curve from a (1+1)D simulation of 100 independent parallel channels each 100 particles in length. (c) Threshold voltage V_T , in units of e/C_0 , versus array length V_T . The line is a fit to $V_T=\alpha N(e/C_0)$, which gives $\alpha=0.25$ for the superlattices formed with excess dodecanethiol.

186807-3 186807-3

a crossover region in which a growing number of parallel channels conduct. This is borne out by the simulated IV characteristic of such a (1+1)D system (Fig. 3b, inset). Depending on the number of independent channels, behavior resembling power laws in the crossover region with exponents ranging from $\zeta \approx 1$ to $\zeta > 2.5$ can easily be reproduced [23]. For sufficiently large v all 1D channels have opened and the overall IV necessarily becomes linear again. Actual arrays most likely are amalgams of locally 2D patches connected by 1D channels. Therefore, once all 1D bottlenecks are filled, the overall IV characteristics are dominated by the remaining 2D patches and ζ approaches a value close to that of ordered 2D arrays. This is the behavior seen in Fig. 3b, where $\zeta \approx 2.7$ in the crossover region turns over to $\zeta = 2.16 \pm 0.1$ beyond $v \approx 2$.

Even for our largest accessible v, the IVs of neither the ordered nor the disordered arrays turn linear (Figs. 3a and 3b), as would be expected once ξ_{\perp} approaches a single lattice spacing. This finding is consistent with results from lithographically patterned arrays below $v \approx 10$ [13] and shows a remarkable extent of the scaling regime.

The thresholds $V_{\rm T}$ obtained from the scaling collapse of the ordered arrays grow linearly with array length, N (Fig. 3c): $V_{\rm T}/(e/C_0) = \alpha N$ with $\alpha = 0.25 \pm 0.02$. Simulations [4] show that α for a given lattice depends only on the capacitive coupling between neighboring particles and decreases as coupling increases; 2D square arrays in the limit $C_{12}/C_0 \rightarrow 0$ give $\alpha = 0.338$. Because of both the larger coordination number in our hexagonal arrays and the finite $C_{12}/C_0 \approx 0.4$ we expect $\alpha < 0.338$, consistent with the measured value. For arrays with large void fraction, N is poorly defined, leading to strongly sample-dependent $V_{\rm T}(N)$ values.

From our findings, two key results emerge. First, sufficiently large amounts of topological disorder, due to voids in the monolayer, lead to distinct deviations from simple power-law behavior in the IV characteristics. In situations where direct imaging is impossible, detailed examination of IVs, therefore, may provide clues about an array's large-scale topology. Second, IV characteristics of long-range ordered arrays are well fit by a single power law, despite the existence of both charge disorder and an inherent wide distribution of tunnel resistances. We believe this indicates that, while R may be exponentially sensitive to variations in the interparticle separation, charge disorder nevertheless plays the dominant role in selecting optimal current paths across the array. The reason most likely lies in the extremely nonlinear, local IV characteristics (Fig. 2, inset), which effectively shut off all current flow unless V_0 is exceeded [24]. Within this picture, our finding of an exponent $\zeta \approx 2.25$ in the structurally well-ordered arrays implies $\eta \approx 1.15$ and thus, as $V_{\rm T}$ is approached from above, a stronger divergence of ξ_{\perp} than would be expected from charge disorder alone (where $\eta \approx 0.67$). In other words, the spread in tunnel resistances appears to produce a more rapid growth of transverse fluctuations in the meandering current paths.

We thank P. Guyot-Sionnest, L. P. Kadanoff, and T. F. Rosenbaum for helpful discussions, and N. W. Mueggenburg and A. W. Smith for experimental assistance. This work was supported by the W. M. Keck Foundation Grant No. 991705, and by the MRSEC program of the National Science Foundation under Award No. DMR-9808595.

- Nanotechnology, edited by G. L. Timp (Springer-Verlag, New York, 1999).
- [2] C. P. Collier, R. J. Saykally, J. J. Shiang, S. E. Henrichs, and J. R. Heath, Science 277, 1978 (1997).
- [3] C. T. Black, C. B. Murray, R. L. Sandstrom, and S. Sun, Science 290, 1131 (2000).
- [4] A. A. Middleton and N. S. Wingreen, Phys. Rev. Lett. 71, 3198 (1993).
- [5] C. P. Collier, T. Vossmeyer, and J. R. Heath, Annu. Rev. Phys. Chem. 49, 371 (1998).
- [6] R. P. Andres et al., Science 273, 1690 (1996).
- [7] A. S. Cordan *et al.*, J. Appl. Phys. **87**, 345 (2000); C. Vieu *et al.*, J. Vac. Sci. Technol. B **16**, 3789 (1998); W. Chen *et al.*, Appl. Phys. Lett. **66**, 3383 (1995).
- [8] M. N. Wybourne et al., Jpn. J. Appl. Phys. 36, 7796 (1997).
- [9] T. L. Morkved et al., Polymer 39, 3871 (1998).
- [10] X.M. Lin et al., J. Nanopart. Res. 2, 157 (2000).
- [11] X. M. Lin, H. M. Jaeger, C. M. Sorensen, and K. J. Klabunde, J. Phys. Chem. B 105, 3353 (2001). Without electrodes present, superlattices routinely exhibit long-range order over microns. Electrodes perturb the monolayer formation, leading to variability in superlattice quality.
- [12] R. Parthasarathy, X. M. Lin, and H. M. Jaeger (to be published).
- [13] Ç. Kurdak et al., Phys. Rev. B 57, R6842 (1998).
- [14] A. J. Rimberg et al., Phys. Rev. Lett. 74, 4714 (1995); C. I. Duruöz et al., Phys. Rev. Lett. 74, 3237 (1995).
- [15] A. Bezryadin et al., Appl. Phys. Lett. 74, 2699 (1999).
- [16] In the limit $C_{12} < C_0$ the effects of changes in s on C_{12} and V_0 [4] are small compared to the exponential impact on R.
- [17] W. R. Smythe, *Static and Dynamic Electricity* (McGraw-Hill, New York, 1950).
- [18] S. Roux and H.J. Herrmann, Europhys. Lett. 4, 1227 (1987).
- [19] D. J. Wold and C. D. Frisbie, J. Am. Chem. Soc. 122, 1970 (2000).
- [20] M. Kardar, G. Parisi, and Y.-C. Zhang, Phys. Rev. Lett. 56, 889 (1986); S. Roux *et al.*, J. Phys. A 24, L295 (1991); H. Hinrichsen, Braz. J. Phys. 30, 69 (2000).
- [21] The KPZ interface roughness exponent z is the ratio of exponents for fluctuations parallel (ν_{\parallel}) and perpendicular (ν_{\perp}) to the growth direction. Intriguingly, linking η to transverse fluctuations only, i.e., $\eta = \nu_{\perp}$ rather than $\eta = 1/z$, and using $\nu_{\perp} \approx 1$ [20] gives $\zeta \approx 2$.
- [22] These "kinks" characteristic of IV curves from disordered samples are robust, and do not depend on normalization or adjustment of V_T.
- [23] For example, for 100 parallel channels of 100 particles each, $\zeta = 2.7$ at the center of the crossover region.
- [24] Current can flow only through paths for which $V > \sum q_i/C_0$, irrespective of whether such paths minimize the overall resistance across the array.

186807-4